

<b>Notice of References Cited</b>	Application/Control No. 10/786,072	Applicant(s)/Patent Under Reexamination ISHII ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2004/0203589 A1	10-2004	Wang et al.	455/410
*	C	US-2003/0018747 A1	01-2003	Herland et al.	709/218
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	J	US-			
	K	US-			
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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